

PASYNKOV, V. V.

May 52

## USSR/Electricity - Personalities

USSR/Electricity - Personalities  
"Connection With His 50th Birthday," P. I.

**"Professor N. P. Bogoroditskiy, in Connection With His 50th Birthday,  
Skotnikov, A. F. Alabyshov, S. Ya. Sokolov, A. A. Vavilov, V. V. Pasynkov,  
B. M. Tareyev**

"Elektricheskoe" No 5, p 88

"Elektricheskoe" No 5, p 80  
Reviews main features of professional life of Nikolay Petrovich Bogoroditskiy, born 20 May 02 in Tashkent. His principal interest has been development of h-f dielectrics. Between 1933 and 1942 he developed the now widely-used radio materials tikond, micalex, h-f glass, radio porcelain, and ultra-porcelain. Affiliations include Military Elec Eng Acad imeni Budenny (1933 - 1942) and a large plant laboratory (where he produced a number of inventions) during World War II. He has published a number of articles in journals, books, and textbooks. He received three Stalin Prizes: for an invention in field of ceramics (1942); for textbook "Electrical Engineering Materials" (1952); and for development and organization of mass production of parts for radio equipment(1952).

PA 240158

BOGORODITSKIY, N.P., PASYNKOV, V.V.; TAREYEV, B.M.; RENNE, V.T., redaktor  
VORONETSKAYA, L.V., tekhnicheskiy redaktor.

[Materials used in electric engineering] Elektrotekhnicheskie  
materialy. Izd-vo 302, pere. Moskva, Gos. energ. izd-vo, 1955.  
(MLRA 8:8)  
372 p.  
(Electric engineering--Materials)

PASYNKO V. V.

5  
6

621.374.832 + 557.311.33  
Semiconducting Ignitors for Ionotron Rectifiers

272

V. V. PASYNKO. [7th, 8th, 9th Ed.] March 1955, Vol. 25, No. 3, pp. 677-683. A detailed report on an experimental investigation is presented, as a result of which methods are proposed for the design and manufacture of ignitors based on silicon carbide.

(b)  
CIA

FD-3175

MAIN CARD

USSR/Physics - Radioactivity, Semiconductors

Card 1/1 Pub. 153-5/21

Author : Pesynkov, V. V.

Title : Influence of radioactive radiation on a photoelement

Periodical: Zhur. tekhn. fiz., 25, No 8 (August), 1955, 1376-1385

Abstract : The author studies the transition of nuclear energy to electrical energy which takes place as a result of the influence of radioactive radiation on semiconductor systems with a blocking layer. The results of experimental measurements are presented in graphical and tabular form. Some of the author's conclusions follow. The influence of beta radiation on a selenium photoelement is analogous to the action of a stream of light and produces an emf. Using known facts about semiconductors it is possible to choose the best semiconductor systems with the largest coefficient of electron multiplication. The use of radioactive isotopes requires that they be studied from the point of view of interaction with semiconductors and the absence of harmful gamma radiation.

Submitted : January 4, 1955

KHARADZHA, Yeofan Nikolayevich; PASYUKOV, V.V., redaktor; ZABRODINA, A.A.,  
tekhnicheskiy redaktor

[General course in X-ray techniques] Obshchii kurs rentgenotekhniki.  
Izd. 2-oe, perer. i dop. Moskva, Gos. energ. izd-vo, 1956. 564 p.  
(X RAYS) (MLRA 9:10)

"APPROVED FOR RELEASE: Wednesday, June 21, 2000 CIA-RDP86-00513R001239

PASYNKOV, V. V.

JMT

APPROVED FOR RELEASE: Wednesday, June 21, 2000 CIA-RDP86-00513R001239

PHASE I BOOK EXPLOITATION

678

Pasynkov, Vladimir Vasil'yevich, Doctor of Technical Sciences

Nelineynyye poluprovodnikovyye soprotivleniya; varistory (Nonlinear Semiconductor Resistances; Varistors) [2d ed., rev. and enl.]  
Leningrad, Leningradskiy Dom nauchno-tehnicheskoy propagandy,  
1957. 35 p. (Series: Obshchestvo po rasprostraneniyu  
politicheskikh i nauchnykh znanii RSFSR. Poluprovodniki, vyp.  
5) 15,000 copies printed.

Sponsoring Agencies: Akademiya nauk SSSR. Institut poluprovodnikov,  
and Leningradskiy Dom nauchno-tehnicheskoy propagandy.

Tech. Ed.: Freger, D.P.; Editorial Board: Ioffe, A.F., Academician,  
(Ed. in Chief); Sominskiy, M.S., Candidate of Physical and  
Mathematical Sciences, (Asst. Ed. in Chief); Maslakovets, Yu. P.,  
Doctor of Physical and Mathematical Sciences; Smolenskiy, G.A.,  
Doctor of Physical and Mathematical Sciences; Shalyt, S.S.,  
Doctor of Physical and Mathematical Sciences; Regel', A.R.,

Card 1/3

Nonlinear Semiconductor Resistances; Varistors 678

Candidate of Physical and Mathematical Sciences; Subashiyev, V.K.,  
Candidate of Physical and Mathematical Sciences; Shagurin, K.A.  
Engineer; Achkinadze, Sh. D., Engineer.

PURPOSE: This brochure is addressed to engineers and technicians  
working with semiconductor devices and materials.

COVERAGE: This monograph is the fifth of the series entitled  
"Poluprovodniki" (Semiconductors). A list of the 18 titles  
constituting the series is given at the end of each brochure.  
[For translations of these titles, see abstract Nr 674.] This  
brochure gives a general introduction to nonlinear resistances,  
and covers such phases of the subject as the characteristics,  
operating principle and production of nonlinear resistances,  
and their applications in industry and technology. There are  
12 Soviet sources (including 1 translation), 4 German, 4 English,  
and 2 French. No personalities are mentioned.

Card 2/3

Nonlinear Semiconductor Resistances; Varistors 678

TABLE OF CONTENTS:

1. General Information on Nonlinear Resistances	3
2. Basic Characteristics of Nonlinear Resistances	4
3. How Nonlinear Resistances Work	9
4. Production of Nonlinear Resistances	10
5. Properties of Nonlinear Resistances	18
6. Applications of Nonlinear Resistances	29
	37

Bibliography

AVAILABLE: Library of Congress

JP/ksv  
10-10-58

Card 3/3

PASYNKOV, V. V.

"Low power Nonlinear Semiconductor Resistances,"  
report presented at the Session on Semiconductors, All-Union Scientific Session  
of VNORiE, Moscow, 20-25 May 1957.

In his lecture V. V. Pasynkov noted that the technology of the manufacture of non-linear resistors for different specified parameters is quite simple, does not require complicated and expensive equipment, and makes it possible to automatize the manufacturing processes in mass production of resistors. Characteristics of resistor specimens developed for telephone engineering are not inferior to the parameters of American specimens obtained from actual apparatus.

Electronic Design, 22 Jan 58

PASYNKOV, Vladimir Vasil'yevich; SAVEL'YEV, Georgiy Anatol'yevich;  
CHIRKIN, Lev Konstantinovich; NASLEDOV, D.N., doktor fiz-  
mat. nauk, prof., retsenzent; SHINKOV, A.D., nauchnyy  
red.; KVOCHKINA, G.P., red.; SHISHKOVA, L.M., tekhn. red.

[Nonlinear semiconductor resistances and their uses] Neli-  
neirye poluprovodnikovye sопротивления и их применение.  
Leningrad, Sudpromgiz, 1962. 211 p. (MIRA 15:11)  
(Semiconductors) (Electric resistors)

OSIPOV, K.D.; PASYNKOV, V.V.; REMEZ, G.A., red.; GOLOVANOVA, L.V.,  
red.; KOCHETKOVA, N.A., red.; KUKOLEVA, T.V., red.

[Reference book on radio measuring devices Spravochnik po  
radioizmeritel'nym priboram. Pod red. G.A.Remeza. Moskva,  
Sovetskoe radio. Pt.5. [Supplement] Dopolnitel'naya.  
1964. 397 p.]

(MIRA 17:6)

FESENKOV, V.V.

(V.A. FESENKOV)

(1951) 1951:001:00000001

COLLECTIVE: "Basic Semiconductors" (Semiconductors in Science and Technology), Vol. 1. Moscow, Izd. Vses. SSSR, 1951. No. 1. 24,000 copies printed.

Editor: V.A. Fesenko, R.A. Karpov, A.P. Gulyaev, V.N. Aronov, R.A.

Contents: The collection of articles on semiconductor devices (theory and technology) is intended for a wide circle of engineers, physicists and technicians.

COVERAGE: The first volume of the collection presents the main concepts of semiconductor theory concerning electric conductivity, thermo- and galvanomagnetic properties, contact phenomena, diffusion and thermoelectric properties. A description of semiconductor devices and their fields of application.

This article discusses the search for heat-resisting semiconductor materials with given electrical and thermal properties to be used in economically profitable thermoelectric generators. The author considers the scientific, technical and economic importance of the semiconductor problem to be equal to that of the problem of utilization of nuclear energy. He presents some general ideas on the electric conductivity of solids and on the concentration and mobility of current carriers (p. 10); on the charge sign of current carriers in semiconductors; on the intrinsic and impurity conductivity of semiconductors (p. 36); on the relation of semiconductor conductance to temperature (p. 49); on semiconductor photoconductivity (p. 61); on the influence of a strong electric field on semiconductor conductance (p. 68); on the influence of various corpuscular radiations on semiconductor conductance (p. 74); on the influence of deformation (p. 78); and on conductance of liquid, amorphous and polycrystalline bodies (p. 80). A table is given of the numerical values of basic physical parameters which

...and of electric conductance of semimetals to 1400°K at low temperature (pp. 82, 83). There are 31 diagrams and charts and 10 references (5 Soviet and 5 translations).

On: II. Stil'bins, L.S. Thermal Conductivity of Semiconductors 86

The author explains the two modes of heat transfer in solids: (1) by means of elastic lattice vibrations, or phonons, and (2) by free electrons. He investigates these two components of thermal conductivity separately. As concerns electronic thermal conductivity, Ioffe, A.F. and Ioffe, A.V.; Detyatkova, Ye. D. and Gul'tyayev, F.V. recently demonstrated that the Wiedemann-Franz Law on the ratio of thermal to electric conductivity is true only as concerns impurity conductivity. As the temperature approaches levels at which intrinsic conductivity appears, thermal conductivity begins to grow more rapidly than electric conductivity. Further investigations in this field were made by Davydov, B.I. and Shmushkevich, I.M. (p. 88). Pikus, G.Ye. derived a formula for complementary thermal conductivity conditioned by exciton diffusion (p. 88). Ansel'm, A.I. demonstrated that the exciton

diffusion coefficient is close to the value of the coupling coefficient of thermal conductivity (p. 88). Crystal lattice thermal conductivity is also analyzed. There are 5 diagrams and 3 references (2 Soviet and 1 a translation).

Ch. III. Stil'bons, L.S. Electron Statistics in Semiconductors. This article explains the Fermi statistics and the Fermi-Dirac distribution function. There are 8 diagrams and 5 Soviet references.

Ch. IV. Stil'bons, L.S. Thermoelectric Phenomena

The article explains the nature of the Peltier and Thomson effects. Between 1930 and 1956 Ioffe, A.F. developed a quantitative thermo-emi semiconductor theory of thermoelectromotive force and of thermoelectric generator generators (p. 115). The TUK-3 type of his supervision is produced in the USSR as a power source for radio collective radio stations of the "Urozhay" type in regions where there is no electric power supply (p. 115). Other models of higher capacity are under development. In 1950, Ioffe

[...] developed a theory of thermoelectric cooling. (The author does not mention the Soviet Union's work in this field.) The author also discusses the possibility of using thermoelectric elements. The Semiconductor Institute, Academy of Sciences of the USSR, has already developed a domestic refrigerator and other devices based on this principle (p. 115). The author derives formulas for the Peltier factor and for the thermoelectromotive force using two different approaches: (1) either to obtain the Peltier factor from kinetic considerations and then to find the thermo-emf from the Thomson formula, or conversely, (2) to find a formula for  $\alpha_1$  (the thermo-emf factor), and then to obtain the Peltier factor from the Thomson relation. He investigates the components of the thermo-emf, namely the contact and volumetric, and then studies the third component, the carrying along of heat. According to the author, this phenomenon

"APPROVED FOR RELEASE: Wednesday, June 21, 2000

CIA-RDP86-00513R001239

CONFIDENTIAL

Semiconductor devices: rectifier p-n diodes; p-n photocells; ZAMP function transistors; microwave frequency p-n-p and n-p-n transistors; p-n-i-p and n-p-i-n transistors; point-contact transistors; channel transistors; and transistors with a wide operating temperature. There are 31 diagrams and drawings and 31 references (7 Soviet, 7 translations, and 20 in English).

CLASSIFIED BY: [redacted] DATE: [redacted] BY: [redacted]

APPROVED FOR RELEASE: Wednesday, June 21, 2000

CIA-RDP86-00513R001239

mechanism of self-diffusion and hetero-diffusion in binary alloys (p. 222). This presentation results from the kinetic theory of real crystals developed by Frenkel, Ye. I. (2) Impurity diffusion in germanium and silicon (p. 226). The author, together with Sozinov, I., recently investigated the diffusion of oxygen in silicon for a temperature range of 800° to 1100° C. (p. 231). (3) Diffusion in sulfur, selenium and tellurium (p. 232). Nasledov, D. and Malyshov, Ye. studied the diffusion of sulfur

Card 9/19

and temperature, basic temperature relationships, static and dynamic characteristics (p. 250). According to the author, Bal'nev G.N. was the first to develop a quantitative theory of energy processes occurring during the operation of thermistors in stationary conditions. This theory made possible the explanation of the electrical static characteristics of thermistors and the creation of bases for the design and construction of thermistors with given characteristics (p. 258). Nechayev, G.K. developed methods of graphic calculation and analysis of a-c circuits with thermistors in which the latter may be combined not only with resistances, but also with inductances and capacitances (p. 260).

II. Basic operational principles in circuits under small and large loads with temperature control or temperature compensation and voltage stabilization, and capacity measurements with DME are discussed (p. 265). Kaganov, M.A. is credited with the development of devices for remote centralized measurement of temperatures (p. 267). Nechayev, G.K. suggested a system of heat control based on utilizing the relay effect arising at a specific temperature in a circuit with

with thermistors (p. 275). The Institute of Electrical Measurements of the Academy of Sciences, USSR, developed and service-tested a system of automatic temperature signaling with thermistors of the KMT-10 type (p. 272). KMT-11 type thermistors are also used for industrial temperature control. An analysis of bridges used for measuring capacities at UHF was made by Kerstenetskaya, F.O. (p. 276).

III. Industrial types of thermistors are described (p. 277) and the work of Kolomyts, B.T., is mentioned as the basis of the Soviet thermistor industry. Types produced in the USSR are enumerated: resistance thermometers of the MMT-1, -4 and KMT-1,-4 types (table of specifications p. 279); thermocompensators of the KMT-8 and -9 types (table p. 283); thermistors for heat control of the KMT-10 and -11 types (characteristics p. 284); voltage stabilizers of the TP2/0.5, TP2/2 and TP6/2 types (table p. 286); capacity meters of 11 types: T8M, T8D, T8R, T8G1, T9 and others; and thermistors with indirect heating of the TRP-300 type (table p. 287). There are 45 illustrations: photographs, drawings and diagrams; 22 references (18 Soviet, 2 translations, 1 in English and 1 German).

1. INVESTIGATION OF THE PROBLEMS OF PRODUCTION AND BASIC CHARACTERISTICS OF SEMICONDUCTOR BOLOMETERS  
The author gives a brief description of the problems of production of bolometers and in particular of semiconductor bolometers (p. 294). The method of producing low-inertia bolometers was described. A highly-sensitive Bi-PB bolometer was produced and developed by Markov, M.N., at the Physics Institute, Academy of Sciences, USSR (p. 293). In 1956 at the Semiconductor Institute, Academy of Sciences, USSR, a method of producing low-inertia Ge bolometers was developed (p. 307). Characteristics of semiconductor bolometers are presented (p. 308-313) and their applications described. There are 12 illustrations: photographs and diagrams, and 22 references (7 Soviet, 3 translations and 12 English and German).

(var3 cont.)  
The author gives a brief description of symmetrical and asymmetrical symmetrical varistors. Symmetrical varistors for voltage up to 1000 V and small currents are produced in some countries, but are not produced by Soviet industry (p. 315). The development of such types of varistors for various parameters is done at the Leningrad Electrical Engineering Institute in Lenin (LEFI), where one type of varistor is produced.

DATE 12/19

experimental production lots are manufactured. Separate samples of the GIEKI at the "Proletariy" Plant (p. 315).

resistances, of the basic characteristics of non-linear resistors for manufacturing varistors and of the procedure for physical characteristics of SiC crystals are presented in tabular form, and the manufacturing process at the "Proletariy" Plant is shown schematically (p. 322). Properties of varistors developed at LETI are presented in tabular form and in a series of characteristic curves for the NPS-42 experimental type (pp. 325-331). Describing the various uses of varistors, the author gives details of their application in valve-type arresters used for overvoltage protection of insulation of 400-kv/a-c electrical installations (pp. 331-336). These arresters were developed by the VEF jointly with the "Proletariy" Plant, where they are produced. The following persons contributed in their development: Ivanov, [redacted]

... Tikhonov, V.I.; Savel'yev, V.P.; Blekman, P.S., and others. D.V. Slobodkin, D.V., is studying the characteristics of the arresters produced. Six basic types of arresters are produced at the "Proletariy" Plant... satisfying the demand for them in the Soviet Union as well as in several foreign countries... (p. 332). Some specifications and basic electric characteristics of the arresters are presented (p. 333), as well as detailed drawings and a photograph. There are 27 illustrations and 23 references (12 Soviet, 2 translations and 9 English, French and German).

Ch. II. Seminckiy, N.S. Photoresistors

338

The author explains the physical origins of photoresistance and the history of its discovery and uses. He describes the methods of making photoresistors and, in particular, of applying the semiconductor layer by the method of evaporation in a vacuum. A rotary vacuum oil pump of the RVN-20 type is used to obtain a preliminary vacuum, and for the high vacuum, diffusion vacuum oil pumps of the TsVL-40 type or TsVL-100 type are used (p. 342). The properties of photoresistances are described. An example is

Card 17/19

given of using for sound reproduction a lead sulfide photoresistor of the FS-A4 type in a narrow-film movie camera of the 16-KPZL-1 type produced in Moscow (p. 349). This proves that photoresistors can operate satisfactorily even with audio frequencies. The high stability of the industrial types of photoresistors is obtained after a definite period of operation, when the final stabilization of their electric properties occurs. Examples are given of the cadmium sulfide photoresistors of the FSK-M1 and FSK-M2 types and of the FS-K1 and FS-K2 types (p. 350). The following photoresistors and their characteristics are described: selenium photoresistors (p. 351); thalofide cells (p. 353); lead sulfide (p. 354); bismuth sulfide (p. 358); cadmium sulfide (p. 361); several types in each category are enumerated and technical data are given. There are 41 diagrams and 30 references (20 Soviet, 3 translations, 1 German and 6 in

With the recent development of semiconductor devices  
the article includes the following: I. General information  
(p. 368). II. Some information on semiconductors with high  
electron mobility (p. 376); data about the following semi-  
conductors are given in detail and presented in a table of  
specifications: Ge, Si, HgSe, HgTe, InAs, InSb; III. Hall emf  
transmitter as a network element (p. 384); a table showing some  
characteristics of transmitters made from different semiconductors  
is presented (p. 389). IV. Practical development of Hall emf  
transmitters and various errors (p. 389); descriptions are given  
of the production of transmitters made with HgSe, HgTe and their  
solid solutions, of cutting of thin semiconductor plates with  
abrasive carbide discs developed at the VNIMASH in Leningrad and of  
the production of contacts. The author discusses the linearity of  
transmitter readings, errors of multiplication, and temperature  
influence. V. The applications of Hall emf transmitters for  
various technical purposes (p. 394) are discussed. Among these  
are measurements of the intensity of constant and variable

Card 16/39

containing a magnetic field (p. 391). Such measurements of the magnetic field were made by the electric motors of the PI-285 series (p. 392) and by V. A. Yelpat'ev, V. A. O.D., and V. Archukov (p. 397) using film transistors and of mercury acetide. As regards measurements of the current and power in p-n and n-p junctions (p. 399), Berman, I. S., from the Semiconductor Institute of the USSR Academy of Sciences, described two types of wave detector in the long wave range (495 to 500 kc) in which the transistors were built using n-Ge and n-In-Sb (p. 301); signal transmission and several aspects of it are described; work in that field by Bogomolov, V. M. (pp. 503, 504) and the use of a linear device by Bogomolov and Vasilev, V. D. in an arrangement for measuring the Hall effect in semiconductors are described (pp. 105, 106). There are 56 diagrams and 66 references (14 Soviet, 22 American, 17 French, German, British and Japanese).

I. Basic parameters of copper oxide rectifiers (18 types) are presented in 3 tables. II. Valves (9 types). III. Basic parameters of selenium rectifiers assembled from rectifying components with an operating voltage of 18 v per unit; there are 25 types of rectifiers of 6 different unit dimensions each having 3 types for the three largest unit dimensions. IV. Basic parameters of selenium rectifiers assembled from rectifying components with an operating voltage of 30 v per unit; there are 25 types of rectifiers of 4 different unit dimensions and 37 types for the 100 x 100 mm rectifier size. V. Basic parameters of Ge diodes at temperatures of  $200 \pm 5^\circ$  C. 7 types are presented. There are 35 photographs and diagrams and 9 references (7 Soviet, 2 translations).

ALEKSANDROV, A.G., dots; ARONOVICH, I.S., inzh.; BABIKOV, M.A., doktor tekhn.nauk; BATUsov, S.V., kand.tekhn.nauk; BEL'KIND, L.D., doktor tekhn.nauk; VENIKOV, V.A., doktor tekhn.nauk; VESELOVSKIY, O.N., kand.tekhn.nauk; GOLOVAN, A.T., doktor tekhn.nauk; GOLUBTSOVA, V.A., doktor tekhn.nauk; GREYMER, L.K., inzh.; GRUDINSKIY, P.G., prof.; GUSEV, S.A., inzh.; DMOXHOVSKAYA, L.P., kand.tekhn.nauk; DROZDOV, N.G., doktor tekhn.nauk [deceased]; IVANOV, A.P., doktor tekhn.nauk [deceased]; KAGANOV, I.L., doktor tekhn.nauk; KERBER, L.L., inzh.; KOCHENOVA, A.I., kand.tekhn.nauk.; LARIONOV, A.N.; MINOV, D.K., doktor tekhn.nauk; NETUSHIL, A.V., doktor tekhn.nauk; NIKULIN, H.V., kand.tekhn.nauk; NILMAYER, R.A., prof.; PANTYUSHIN, V.S., prof.; PASYUKOV, V.V., doktor tekhn.nauk; PETROV, G.N., doktor tekhn.nauk; POLIVANOV, K.M., doktor tekhn.nauk; PRIVEZEMTSEV, V.A., doktor tekhn.nauk; RADUNSKIY, L.D., inzh.; RENNE, V.T., doktor tekhn.nauk; SVENCHAIISKIY, A.D., doktor tekhn.nauk; SOLOV'YEV, I.I., doktor tekhn.nauk; STUPEL' F.A. kand.tekhn.nauk; TALITSKIY, A.V., prof.; TEMNIKOV, F.Ye., kand.tekhn. nauk; FEDOROV, L.I., inzh.; FEDOSEYEV, A.M., doktor tekhn.nauk; SHNEY-KHOLYAVSKIY, G.B., inzh.; CHECHINT, Yu.S., doktor tekhn.nauk; SHUMILOVSKIY, H.H., doktor tekhn.nauk; BURG, Ya.A., kand.tekhn.nauk; SHUMILOVSKIY, H.H., doktor tekhn.nauk; ANTIK, I.B., red.; MEDVERELEV, L.Ya., tekhn.red.

[The history of power engineering in the U.S.S.R. in three volumes]  
Istoriia energeticheskoi tekhniki SSSR v trekh tomakh. Moskva, Gos. energ. izd-vo.

(Continued on next card)

ALEKSANDROV, A.G.--(continued) Card 2.

Vol.2. [Electric engineering] Elektrotehnika. Avtorskii kollektiv  
toma: Aleksandrov i dr. 1957. 727 p.  
(MIRA 11:2)  
1. Moscow. Moskovskiy energeticheskiy institut. 2. Chlen-korrespon-  
dent AN SSSR (for Larionov)  
(Electric engineering)

BOGORODITSKIY, Nikolay Petrovich; FRIDBERG, Ilariy Dmitriyevich;  
PASYNKOV, V.V., red.; SOBOLEV, Ye.M., tekhn.red.

[Electrophysical characteristics of high-frequency ceramics]  
Elektrofizicheskie osnovy vysokochastotnoi keramiki. Moskva,  
Gos.energ.izd-vo, 1958. 191 p. (MIRA 12:3)  
(Ceramic materials--Electric properties)

SOV/58-59-8-18420

Translated from: Referativnyy Zhurnal Fizika, 1959, Nr 8, p 200 (USSR)

AUTHORS: Pasynkov, V.V., Savel'yev, G.A.

TITLE: Low-Power Nonlinear Semiconductor Resistors (Varistors)

PERIODICAL: V sb.: Primenenie poluprovodnikov v elekrotekhn., Lenin-grad, 1958, pp 95-114

ABSTRACT: Nonlinear semiconductor resistors (varistors) are described, which are manufactured from silicon carbide and have a nonlinear volt-ampere rating. It is demonstrated that their volt-ampere rating can be approximated on a certain section by an exponential function. The coefficient of nonlinearity depends on the applied voltage and can vary from 2 to 3.5. Theories are advanced to explain the nonlinearity of the volt-ampere characteristic of varistors. The authors hold that the parallel action of several mechanisms clarifying nonlinearity is possible under concrete conditions. The technology of producing such resistors is briefly described. It is noted that these mechanisms must

Card 1/2

SOV/58-59-8-18420

Low-Power Nonlinear Semiconductor Resistors (Varistors)

be made thoroughly hermetic in order to ensure stability. The authors cite the methods and results of testing resistors manufactured in the Leningrad Electro-technical Institute. Applications of nonlinear semiconductor resistors are described in several circuits, as, for example, for stabilizing voltage, increasing the frequency, etc. The bibliography contains 23 titles.

G.K. Nekhayev

Card 2/2

PHASE I BOOK EXPLOITATION

SOV/4217

Osipov, Konstantin Dmitriyevich, and V.V. Pasynkov

Spravochnik po radioizmeritel'nym priboram, chast' 4: Spetsial'nyye izmeritel'-nyye pribory i istochniki pitaniya (Handbook on Radio Measuring Instruments, Pt. 4: Special Measuring Instruments and Electric Current Supply). Moscow, Izd-vo "Sovetskoye radio," 1959. 152 p. No. of copies printed not given.

Ed. (Title page): G.A. Remez; Ed. (Inside book): Yu.I. Sukhanov; Tech. Ed.: B.V. Smurov.

PURPOSE: This handbook is intended for technical personnel engaged in the development, operation, and repair of radio engineering equipment and radiometers.

COVERAGE: This volume is the fourth part of a 4-part work on radio measuring instruments. It covers instruments for measuring field strength and low h-f voltages, special and auxiliary meters for measuring at super high frequencies, electron tube testers, and electric current supplies of radio systems. The authors thank G.A. Remez, V.G. Dubenetskiy, and V.N. Sretenskiy. No references are given.

Card 1/6

PASYNKOV, V V

PHASE I BOOK EXPLOITATION SOV/4102

Osipov, Konstantin Dmitrovich, and V.V. Pasynkov

opravochnik po radioizmeritel'nym priboram, ch 3: Pribory dlya izmereniya  
formy kolebaniy (Handbook on Radio Measuring Instruments, Pt 3:  
Instruments for Measuring Shape of Oscillations) Moscow, Izd-vo  
"Sovetskoye radio," 1959. 170 p. Errata slip inserted. No. of  
copies printed not given.

Ed. (Title page): G.A. Remez; Ed. (Inside book): V.G. Masharova;  
Tech. Ed.: B.V. Smurov.

PURPOSE: This handbook is intended for engineers and technicians en-  
gaged in the development, operation, and repair of radio equipment  
and radio measuring instruments.

COVERAGE: The handbook gives detailed information on electronic os-  
cilloscopes, special oscillographic devices, spectrum and frequency  
response analyzers, modulation meters, nonlinear distortion measur-  
ing equipment, and measuring amplifiers. The book also gives in-

Card 1/5

Handbook on Radio (Cont.)

SOV/4102

formation on general purpose, serial production radio measuring instruments, and on instruments which, though out of production, are still widely used. The authors thank G.A. Rerez, V.G. Dubenetskiy, and V.N. Sretenskiy. There are no references.

TABLE OF CONTENTS:

Introduction	3
Ch. I. Electronic Oscillographs (Oscilloscopes)	8
Electronic audio-frequency oscillograph I-304	8
Electron-beam oscillograph ENO-1	12
Electronic oscillograph EO-4	17
Electronic oscillograph EO-7	21
Electronic oscillograph EO-6M	24
Electronic oscillograph 25-I	27
Electronic oscillograph IO-4	29
Electronic oscillograph EO-53	34
Electronic oscillograph SI-1 (pulse synchronoscope)	38
Electronic miniature oscillograph EMO-2	44

Card 2/5

Handbook on Radio (Cont.)

SOV/4102

Double-beam electronic oscilloscope OK-17M	47
High-voltage oscilloscope OK-15M	50
High-voltage oscilloscope OK-19M	53
Double-beam pulse electronic oscilloscope OK-21	57
Double-beam pulse oscilloscope OK-25	60
Ch. II. Special Oscillographic Devices, Spectrum and Frequency Response Analyzers	
Oscillographic zero indicator INO-3	64
Oscillographic zero indicator INO-3M	67
Oscillographic timer IV-13M	70
Oscillographic timer IV-22	72
Transient recorder IPKh-1	75
Spectrum analyzer and frequency response characteristic recorder ASChKh-1	78
Frequency response characteristic recorder IChKh-1	82
Sweep generator 102-I	87
Spectrum analyzer IV-46	90
Spectrum analyzer IV-66	94
	102

Card 3/5

## Handbook on Radio (Cont.)

SOV/4102

Ch. III. Modulation Meters	107
Modulation meter IM-8	109
Modulation meter IM-13	111
Modulation meter IM-20	115
Combined current and modulation meters	119
ITM-1M and ITM-3M	119
Combined current and modulation meter ITM-5	121
Frequency modulation meter IChM-5	123
Modulation meter IM-18	127
Modulation meter IM-19	130
Ch. IV. Nonlinear Distortion Meters	134
Nonlinear distortion meter INI-7	135
Nonlinear distortion meter INI-10M	138
Nonlinear distortion meter INI-11	140
Voltage analyzer AN-1-50	143
Ch. V. Measuring Amplifiers	147
Cathode follower 42-I	147
Measuring amplifiers 28-I and 28-IM	148

Card 4/5

- PASYNKOV V V

PHASE I BOOK EXPLOITATION SOV/4410

Sipov, Konstantin Dmitriyevich, and Vsevolod Vladimirovich Pasynkov

pravotnik po radioizmeritel'nym priboram, chast' I: Pribory dlya izmereniya  
toka, napryazheniya, moshchnosti i parametrov elementov skhem (Handbook on  
Radio Measuring Instruments, Pt 1: Instruments for Measuring Current, Voltage,  
Power, and Parameters of Circuit Elements). Moscow, Izd-vo "Sovetskoye Radio,"  
1959. 220 p. Errata slip inserted. No. of copies printed not given.

Ed. (Title page): G.A. Remez; Ed. (Inside book): N.Ya. Arenberg; Tech. Ed.:  
B.V. Smurov.

PURPOSE: This handbook is intended for technical personnel engaged in designing,  
operating or repairing radio engineering or radio measuring equipment.

COVERAGE: This first part of the handbook contains information on radio measuring  
instruments of general application whose purpose is to measure the values of cur-  
rent, voltage, power, capacitance, inductance, circuit Q-factors, resistances  
and reactances. The description of each instrument consists of the following  
sections: purpose and field of application, basic technical characteristics,

Card 1/7

*Handbook on Radio Measuring Instruments (Cont.)*

SOV/4410

brief description of a circuit and of the principle of action, operating set of replaceable components and their assembly. The basic circuit is given for all instruments, and a block diagram is presented for the more complex ones. The authors thank G.A. Remet' for his help and V.G. Dubenetskiy and V.N. Sretenskiy for their useful advice. There are no references.

## TABLE OF CONTENTS:

Introduction	1
Ch. I. Current and Voltage Meters	
General information	5
Instruments of the Thermolectric System	
Ammeter T-12	5
Milliammeter T-13	14
Thermal converters T-101, T-102, and T-103	15
Contactless vacuum thermal converters TVB	16
Instruments of the Electrostatic System	
Voltmeter S-91	17
Voltmeter S-92	18
	20

Card 2/7

<sup>†</sup>A. S. Nikov, V. V.

007/19-59-3-1/5  
Khainov, V. I. Engineer  
The Inter-university Scientific Conference  
on Practical Measuring Instruments and on the Technical  
Means of Automation (Measuring Means, Automatic  
Control Systems, etc.)  
Concerning the Possibility of Electroacoustic  
Registration of Seismic Vibrations  
Kharkov Institute of Civil Engineering

PERIODICALS,  
ABSTRACTS.

Priborotrobyanye, 1959, № 5, pp. 30-31 (1533).  
 This Conference was held at the Leningradsky elektricheskii in-t (Institute of Electrical Engineering), Leningrad, on November 1, 1958. It was attended by 120 persons (lecturers, 11; Engineers, 100; students, 1; UI Yarne (local) ) in October 1958. It was attended by more than 300 representatives of universities, scientific research institutes, of the GDR, the USSR (Special Design Office), of industries and other organizations. More than 30 lectures were delivered in the course of this Conference. In opening the conference P. P. Boroditsky underlined the outstanding importance of automation

Card 1/5

**Control of Production Data** and outlined the extensive possibilities of using radioactive methods in such a control. Yu. G. Shirakov and S. A. Specter reported on a new method of measuring heavy direct currents with the help of the nuclear magnetic resonance. M. A. Rosenblat investigated problems of the application of magnetic amplifiers in automation and in assuring technique. A. V. Fafeyev reported on the present-day state on the prospects of astomatic control technique. Ya. Z. Taykin investigated some peculiar features of and the prospects offered by astomatic pulse systems. The lecture by M. G. Boldyrev dealt with problems of stability of discrete automatic systems. V. D. Ushakov discussed the main trends in development of mathematical analog computers and of computers designed for industrial use. The report by V. S. Ryabikin deals with an electronic analog correlator for the calculation of correlation functions in the investigation of winds in the ionosphere. R. I. Furmanov reported on the most important methods, which guarantee both an active and passive freedom from disturbances in discrete selective systems. Ya. V. Korolev's discussed problems of averaging, differentiation, and balancing.

of time-dependent functions which can be represented by electric signals. V. P. Skurikhin investigated new computing devices with polarized relay. A. V. Freake and Ye. M. Dubinin reported on instruments for automatic instruments with automatic recording. V. S. Ushakov and N. V. Kopyt'科va reported on a computer for the automatic centralized control of production specifications. M. M. Gerasimov discussed fundamental problems of the theory of automatic measuring instruments with an inverse conversion for the measurement of non-electric quantities. Fe. I. Pavlov dealt with problems of the construction of automatic d. - c. potentiometers with high accuracy. D. I. Malov discussed a high-precision automatic d. c. bridge for digital computations. The participants in the Congress listed below discussed the following subjects (enriched, however, are not given by the exact wording of the titles):  
T. A. Korobova. The planning of  
T. A. Korobova. The planning of

26

PAGE - 2

The Inter-university Scientific Conference on  
Electrical Measuring Instruments and on the Technical  
Means of Automation 307/119-59-3-15/15

Accurate automatic galvanic-type meters in digital computations.  
B. I. Kharchenko Methods of determining the dynamic errors  
of a magnetic oscilloscope by sinusoidal quantities. P. P. Ornatskii  
Measures by measuring electric quantities extremely low  
frequencies. L. F. Kulinovskiy Various instruments of various  
types of galvanometric indicators suited for the control of a. a. compensation  
series production. S. I. Stolov Parameters of condensers  
bridge induction. S. I. Stolov Some characteristics  
technique and automation which can be used in measuring of  
pressure and liquid level. G. Yu. A. Serpukhov  
a. a. semi-equilibrium bridges. The  
of instruments with magnetic bridges. A. P. Surde. The application  
and the circuitry simplification of bridges, which permit a  
quantities. V. A. Frants The results of the apparatus  
sensitivity of oxygen gas analysers. P. V. Klyuchnikov  
Design of apparatus for measuring vibrational  
parameters. Main types of non-linear vibration quantities.  
Koropashenya's possibilities of their application to  
semiconductor development and measuring technique. G. K.  
Ye. Te. Afanasyev. Ye. P. Gulyayev. M. A. Savchenko  
frequency meter operating according to the pulse-counting  
principle. P. G. Kuzin and A. S. Sizukhin. Method of  
measuring the magnetic field  
resistors and transducers operate on the basis of  
principle. A resolution was adopted by means of discussion  
meeting of the Conference. The circuit of the current  
imposing and operating, which indicates the  
field of automation, coordinatizing scientific researches of  
techniques. Accurate measuring and computing

Card 4/5

Card 5/5

KARPOV, Yu. S., PASYNKOV, V.V.

In regard to the article "Terminology in the field of  
transistor electronics". Izv. vys. ucheb. zav.; radiotekh.  
2 no.6:750-751 N-D '59. (MIRA 13:6)

1. Kafedra dielektrikov i poluprovodniko Leningradskogo  
elektrotekhnicheskogo instituta imeni V.I. Ul'yanova  
(Lenina).  
(Transistor--Terminology) (Agakhanian, T.M.)  
(Kononov, B.N.) (Stepanenko, I.P.)

PHASE I BOOK EXPLOITATION SOV/5569

Osipov, Konstantin Dmitriyevich, and Vsevolod Vladimirovich  
Pasynkov

Spravochnik po radioizmeritel'nym priborom. ch. 2: Pribory dlya  
izmereniya chastoty i izmeritel'nyye generatory (Manual on Radio  
Measuring Devices. pt. 2: Frequency-Measuring Devices and  
Measuring Generators) Moscow, Izd-vo "Sovetskoye radio," 1960.  
203 p. No. of copies printed not given.

Ed. (Title page): G. A. Remez; Eds.: N. A. Kochetkova and Yu. I.  
Sukhanov; Tech. Ed.: B. V. Smurov.

PURPOSE : This manual is intended for technical personnel engaged  
in the development, operation, or maintenance of radio engineer-  
ing and radio measuring equipment.

COVERAGE: This part of the manual contains information on reso-  
nance and heterodyne frequency meters and measuring oscillators  
(1-f oscillators, signal generators, and standard signal gener-  
ators). The description of each instrument consists of the

Card 1/5

Manual on Radio Measuring (Cont.)

SOV/5567

following sections: purpose and field of application, basic technical characteristics, a brief description of circuit and principle of operation, operating set of changeable components, and list of additional parts. Moreover, the manual includes a description of the external shape and the schematic diagram of each instrument, as well as block diagrams of complex devices. The authors thank V. G. Dubenetskiy and V. N. Sretenskiy for their advice. There are no references.

TABLE OF CONTENTS:

Introduction

Ch. I. Instruments for Frequency Measurements	3
General information	
ICh - 5, ICCh - 5A frequency meter	5
ICh - 6 frequency meter	7
Resonance wavemeter 513	9
UVR (UVR-I, UVR-II) microwave resonance wavemeter	11
VMT-1 low-precision wavemeter	12
Card 2/5	14

PHASE I BOOK EXPLOITATION

SOV/5058

Bogoroditskiy, N. P., and V. V. Pasynkov, eds.

Spravochnik po elektrotekhnicheskim materialam. V dvukh tomakh.  
t. 2; Magnitnyye, provodnikovyye, poluprovodnikovyye i drugiye  
materialy (Handbook on Electrical Engineering Materials. In  
two volumes. Vol. 2; Magnetic, Conducting, Semiconducting, and  
Other Materials) Moscow, Gosenergoizdat, 1960. 511 p. Errata  
slip inserted. 30,000 copies printed.

Eds. of Handbook: K. A. Andrianov, N. P. Bogoroditskiy,  
Yu. V. Koritskiy, V. V. Pasynkov, and B. M. Tareyev; Eds. (This  
vol.): N. P. Bogoroditskiy and V. V. Pasynkov; Tech. Ed.:  
Ye. M. Soboleva.

PURPOSE: This handbook is intended for technical personnel of elec-  
trical and radio engineering establishments, power stations and  
substations, electric repair shops, laboratories, and scientific  
research institutes.

Card 1/19

Handbook on Electrical Engineering (Cont.)

SOV/5058

PART II. CONDUCTING METALLIC MATERIALS AND ELECTRICAL CARBON

Ch. XII. Classification and Properties of Solid Conductors of Electric Current (V. V. Pasynkov)

1. Classification	117
2. Basic properties	117
3. Summary tables of miscellaneous metals' characteristics	121

Ch. XIII. High Conductivity Materials (V. V. Pasynkov)

1. Copper	122
2. Aluminum	133
3. Steel wire and ferroaluminum cables	138

Ch. XIV. Copper and Aluminum Alloys (V. V. Pasynkov)

1. Bronze	140
2. Brass	154
3. Aluminum alloys	169

Card 8/19

Handbook on Electrical Engineering (Cont.)

SOV/5058

3.	Bases of manufacturing processes and types of thermoresistors	394
4.	Values characterizing properties of thermoresistors	395
5.	Some problems of practical application of thermoresistors	396
6.	Soviet-produced thermoresistors	397
Ch. XXVII. Nonlinear Resistors Based on Silicon Carbide (Z. F. Vorobey and V. V. Pasynkov)		
1.	General information on nonlinear resistors	400
2.	Properties of silicon carbide	401
3.	Bases of the manufacturing processes of nonlinear resistors	404
4.	Properties and application of nonlinear resistors	405
Bibliography to Part III [60 references: 46 Soviet, 9 English, 1 French, and 4 German]		408

Card 15/19.

**Handbook on Electrical Engineering (Cont.)**

SOV/5058

5. Carbon electrodes for welding	289
6. Carbon electrodes for illumination	290
7. Carbon electrodes for galvanic cells	294
8. Carbon products for communications equipment	295
9. Electrical carbon products (for electric vacuum and gas-discharge devices)	298
10. Brushes for electric machinery	300
11. Miscellaneous carbon products	314

**Bibliography to Part II [94 references: 64 Soviet, 23  
English, 5 German, 1 Czech, and 1 French]**

317

**PART III. SEMICONDUCTOR MATERIALS AND PRODUCTS**

**Ch. XXII. Basic Information on Semiconductors (V.V. Pasynkov)**

1. Introduction	319
2. Ideas on the mechanism of electric conductivity	320

Card 12719

BEREZIN, Boris Mikhaylovich; PASYNKOV, V.V., prof., doktor tekhn.nauk,  
otv.red.; VARKOVETSKAYA, A.I., red.; TSAL, R.K., tekhn.red.

[Materials for electricians in shipbuilding] Materialovedenie  
dlia elektrikov-sudostroitelei. Leningrad, Gos.sciuznoe izd-vo  
sudostroit.promyschl., 1960. 212 p. (MIRA 13:5)  
(Shipbuilding--Supplies) (Electricity on ships)

172 YANKEVICH

## PROCEEDINGS OF THE CONFERENCE

## SESSIONS

**Verschiljennost' i ogranichenie v fizike poliyelektrikov** 11 164-2  
[Variation and Limitations in the Physics of Dielectrics] 11

**Prilozheniya i issledovaniya v oblasti poliyelektricheskikh i magneticheskikh materialov** 12 164-2  
[Applications and Research in the Field of Dielectric and Magnetic Materials] 12

**Spetsialnye i obshchye zadaniya fizicheskogo instituta imeni P. S. Letokhova** 13 164-2  
[Special and General Tasks of the Physics Institute named after P. S. Letokhov]  
Ed. of Publishing House "Nauk. i Tekhn. Izd." Doctor of Physics and Mathematics, V. M. Kondratenko and I. V. Filimonova, Collective of Authors and Editors, 160 p. Printed slip (unprinted). 4000 copies printed.

**Prilozheniya i obshchye zadaniya fizicheskogo instituta imeni P. S. Letokhova** 14 164-2  
[Applications and General Tasks of the Physics Institute named after P. S. Letokhov]

Two groups of reports.

**CONFERENCE "THE SECOND ALL-SOVIET CONFERENCE ON THE PROBLEMS OF DIELECTRICS" HELD IN BEIJING** 15 164-2  
Meeting of the First Soviet Delegation to China, Physics Institute being part of the delegation was attended by representatives of the principal scientific centers of the USSR and of several Chinese universities. This collection contains most of the reports presented at the conference and summaries of the discussions which followed. The reports in this collection deal with dielectric properties of various crystals, electrical compounds and ceramics. Properties of ferroelectric crystals and certain radiators of interest for physics presented at the conference dealing with polarization, dispersion, and frequency dependences of dielectrics which were published in the journal "Fizika i prirodovedenie" (Physics and Nature) No. 20. No personalities are mentioned.

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 16 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**TEHNIKA IZMERENII I VYKONIVANII** 17 164-2  
[Technique of Measurement and Execution]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 18 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 19 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 20 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 21 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 22 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 23 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 24 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 25 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 26 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 27 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 28 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 29 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 30 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 31 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 32 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 33 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 34 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 35 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 36 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 37 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 38 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 39 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 40 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 41 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 42 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 43 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 44 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 45 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 46 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 47 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 48 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 49 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 50 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 51 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 52 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 53 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 54 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 55 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 56 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 57 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 58 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 59 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 60 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 61 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 62 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 63 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 64 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 65 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 66 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 67 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 68 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 69 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 70 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 71 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 72 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

**IZMENENIYA V DNEVNOJ TEPLOPESCHTY I TEPLOTY** 73 164-2  
[Changes in Daily Heat Production and Temperature Dependence]

9.2100

81356

S/181/60/002/03/10/028  
B006/B017

AUTHORS: Pasynkov, V. V., Kholuyanov, G. F., Chirkin, L. K.

TITLE: Dynamic Current-voltage Characteristics of Silicon Carbide  
Resistors

PERIODICAL: *Fizika tverdogo tela*, 1960, Vol. 2, No. 3, pp. 434-437

TEXT: In recent times, the number of low-voltage nonlinear silicon carbide resistors has widely increased; the maximum current densities in these apparatus do not exceed  $1 - 2 \text{ a/cm}^2$ . Basing on the same principle the authors produced resistors from green and black silicon carbide, and investigated their dynamic current-voltage characteristics at low current densities by means of an apparatus the circuit of which is shown in Fig. 2. The current-voltage characteristics show essential deviations from the ordinary ones (Fig. 1). Figs. 3a and 3b show typical dynamic characteristics of resistors of green silicon carbide (sample thickness: 1.5 mm, area:  $75 \text{ mm}^2$ ; natural capacitance: 30 pf). The oscillograms were recorded with pulse durations of 30 and 20  $\mu\text{sec}$  (pulse

Card 1/3

X

Dynamic Current-voltage Characteristics of  
Silicon Carbide Resistors

81356

S/181/60/002/03/10/028  
B006/B017

height: 138 v). The hysteresis of the characteristics is a result of the natural capacitance of the nonlinear resistor. The succession of the branches of the hysteresis loop was determined by charging and discharging the capacitance of the samples. The hysteresis loop in the initial part of the current-voltage characteristic widened with increasing steepness of the pulse fronts. At low current densities, the microheatings of the contacts between the crystals had no essential influence on the nonlinearity of the resistors. With increasing voltage the resistance of the samples decreases, the influence of natural capacitance decreases as well, and the dynamic current-voltage characteristic approaches the static one. The capacitance of the nonlinear resistors of black and green silicon carbide does not vary within the frequency range 50 kc/s - 25 Mc/s. The dielectric constant of a non-homogeneous resistor material raises the natural dielectric constant of silicon carbide considerably. This phenomenon is connected with the presence of polarizations within the layers of a non-homogeneous material. The capacitance of the nonlinear resistors does not depend on the constant displacement voltages. There are 4 figures and 6 references:

Card 2/3

X

Dynamic Current-voltage Characteristics of  
Silicon Carbide Resistors

81356  
S/181/60/002/03/10/028  
B006/B017

2 Soviet, 2 French, 1 Swiss, and 1 German.

ASSOCIATION: Leningradskiy elektrotekhnicheskiy institut im. V. I.  
Ul'yanova (Lenina) (Leningrad Electrotechnical Institute  
imeni V. I. Ul'yanov (Lenin))

SUBMITTED: May 11, 1959

4

Card 3/3

PASYNKOV, V., Inzh.

A pamphlet on achievements in radioelectronics. Prof.-tekhn. obr.  
17 no.6:28 Je '60. (MIRA 13:7)  
(Electronic apparatus and appliances)

PASYNKOV V V

PHASE I BOOK EXPLOITATION

SOV/5389

Bogoroditskiy, Nikolay Petrovich, and Vladimir Vasil'yevich  
Pasynkov

Materialy v radioelektronike (Materials in Radio Electronics)  
Moscow, Gosenergoizdat, 1961. 352 p. 45,000 copies printed.

Ed.: Ya. I. Panova, Candidate of Technical Sciences; Tech. Ed.:  
Ye. M. Soboleva.

PURPOSE: This book has been approved by the Ministry of Higher  
and Secondary Special Education, RSFSR, as a textbook for  
radio engineering schools of higher education and university  
divisions. It may be also useful to technical personnel en-  
gaged in radio electronics.

COVERAGE: The book presents the principles of the phenomena  
occurring in insulating, semiconductor, conductor, and mag-  
netic radiotechnical materials. Their electrical properties,  
especially at elevated and high frequencies, and their

Card 1/6

Materials in Radio Electronics

SOV/5389

physicochemical and mechanical characteristics are described. The production technology of numerous radiotechnical materials and their use in the manufacture of articles and components used in radio engineering are briefly examined. The authors thank the following persons: D. N. Nasledov, Professor, Head of the Department of Physics of the Leningradskiy politekhnicheskij institut im. M. I. Kalinina (Leningrad Polytechnical Institute imeni M. I. Kalinina); A. N. Tekuchev, Professor, head of the committee of teachers of the Ryazanskiy radiotekhnicheskij institut (Ryazan' Institute of Radio Engineering), who reviewed the book; and G. I. Panteleyeva, who helped with the manuscript. There are 25 references, all Soviet (including 2 translations).

TABLE OF CONTENTS:

Designations of Basic Quantities Adopted in This Book

7

Introduction

Card 2/6

BOGORODITSKIY, Nikolay Petrovich; PASYNKOV, Vladimir Vasil'yevich;  
TAREYEV, Boris Mikhaylovich; RENNE, V.T., doktor tekhn.nauk, prof.,  
red.; ZHITNIKOVA, O.S., tekhn.red.

[Electric engineering materials] Elektrotekhnicheskie materialy.  
Izd.4., perer. Moskva, Gos.energ.izd-vo, 1961. 528 p.

(MIRA 14:6)

1. Zaveduyushchiy kafedroy elektroizolyatsionnoy i kabel'noy  
tekhniki Leningradskogo politekhnicheskogo instituta im. M.I.Kalinina  
(for Renne).

(Electric engineering--Materials)

ACC NR: AF/003648

(N)

SOURCE CODE: UR/0020/67/172/001/0083/0086

AUTHOR: Volokobinskiy, Yu. M.; Lototskiy, B. Yu.; Pasynkov, V. V.; Chirkin, L. K.

ORG: none

TITLE: Thermal processes in thin films

SOURCE: AN SSSR. Doklady, v. 172, no. 1, 1967, 83-86

TOPIC TAGS: semiconducting film, dielectric coating, volt ampere characteristic, thermal effect

ABSTRACT: The authors show that in thin semiconductor and dielectric films, local inhomogeneities of the thermal properties can play an important role and lead in a number of cases to S-shaped or N-shaped volt-ampere characteristics. The effect of thermal inertia of homogeneous semiconductor and dielectric films operated at alternating current on the volt-ampere characteristics is analyzed by expanding in Fourier series the heat flow and the temperature variation in both the film and substrate. The effect of substrate thickness is discussed. The results show that homogeneous films deposited on thick substrates have a larger thermal inertia and even at low frequencies the temperature of the film lags the changes in the heat release. It is shown that materials in which the conductivity decreases with temperature in a certain temperature interval cannot be analyzed by the same procedure as a uniform film. Some experimental results confirming the analysis are presented for  $\text{Al}_2\text{O}_3$  films. This report was presented by Academician B. P. Konstantinov 10 March 1966. Orig. art. has:

Card 1/2

537:

UDC: 539.216.22: 539.216.22: 536

ACC NR: AP7003648

2 figures and 16 formulas.

SUB CODE: 20/ SUBM DATE: 03Feb66/ OTH REF: 002

Card 2/2

BALODIS, Yu.N., PASYNKOV, V.V.

Low-voltage thin-film nonlinear elements. Izv. vys. ucheb.  
zav.; prib. & no. 3elli-16 '65. (MIRA 18:1)

Le Leningradskiy elektrotekhnicheskiy institut imeni Ul'yanova  
(Lenina). Rekomendovana kafedroy dielektrikov i poluprovodnikov.

KURNOSOV, Anatoliy Ivanovich; YUDIN, Vladimir Vasil'yevich;  
ALFEROV, Zh.I., kand. tekhn. nauk, retsenzent;  
MITROFANOV, V.V., inzh., retsenzent; PASYNKOV, V.V.,  
prof., doktor tekhn. nauk, nauchn. red.; CHFAS, M.A.,  
red.; KVOCHKINA, G.P., red.

[Technology of the manufacture of semiconductor devices]  
Tekhnologija proizvodstva poluprovodnikovykh priborov.  
Leningrad, Sudostroenie, 1965. 247 p. (MIRA 18:8)

L 5440-66

EWT(1)/EPA(s)-2/EWT(m)/EWP(t)/EWP(b) IJP(c) JD/WH/JG  
ACCESSION NR: AP5019763 UR/0051/65/019/002/0281/0283

AUTHOR: Golovkina, E. D.; Pasynkov, V. V.; Khanina, G. N.

TITLE: Low-voltage electroluminescence of evaporated ZnS-Cu, Mn, Cl films in a  
dc field

SOURCE: Optika i spektroskopiya, v. 19, no. 2, 1965, 281-283

TOPIC TAGS: electroluminescence, zinc compound optic material, luminor, volt ampere  
characteristic, optic brightness

ABSTRACT: The authors obtained thin-film specimens which became electroluminescent  
in a low-voltage dc field by evaporating the ready-made EL-580 electroluminor in  
vacuum ( $\sim 5 \times 10^{-5}$  mm Hg) on a heated glass substrate with  $\text{SnO}_2$  layer. The construc-  
tion of the resultant luminor film is shown in Fig. 1 of the Enclosure, which in-  
cludes the volt-ampere and voltage-brightness characteristics. The over-all film  
thickness was 3-5  $\mu$ . The volt-ampere characteristics were measured by a standard  
technique. The brightness was measured with a selenium photocell. The specimens  
produced could be divided into two groups, one of which (I) became electrolumines-  
cent when the aluminum electrode was positive, and the other (II) became electro-  
luminescent with both negative and positive polarity. The groups differed in

Cord 1/3

L 5440-66  
ACCESSION NR: AP5019763

brightness, voltage required to produce luminescence, current-carrying capacity, aging, emission intensity, and other characteristics. All these effects can be related to changes in the electrical resistance and thickness of the dielectric layer between the electrode and the luminor. Most promising from the point of view of practical applications is operation with negative polarity on the metallic electrode. Orig. art. has: 2 figures.

ASSOCIATION: none

SUBMITTED: 03Jun64

ENCL: 01

SUB CODE: OP, 55

MR REF SOV: 001

OTHER: 001

Card 2/3

L 5440-66

ACCESSION NR: AP5019763

ENCLOSURE: 01

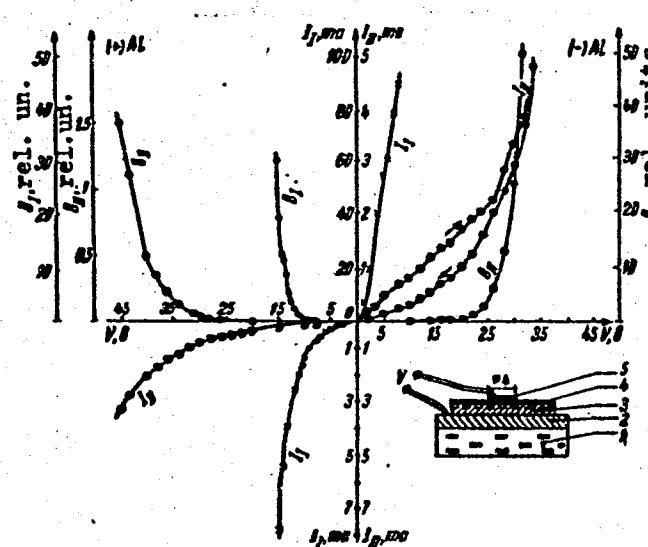


Fig. 1. Volt-ampere and voltage vs. brightness characteristics of electroluminescent thin films after 3 hours' operation at the highest voltage and at a given polarity. The structure of the film is shown in the lower right corner of the figure.

- 1 - Glass substrate,
- 2 - conducting layer,
- 3 - evaporated electroluminor,
- 4 - insulating SiO layer,
- 5 - aluminum electrode.

Card 3/3 Red

L 57603-65 EWT(1)/EEC(b)-2/EWA(h) Peb/P1-4

ACCESSION NR: AR5000577

3/0271/64/000/009/B016/B017

681.142.6

33

SOURCE: Ref. zh. Avtomat. telemekh. i vychisl. tekhn. Sv. t., Abs. 9B115

29

AUTHOR: Korovitskiy, S. L.; Pasynkov, V. V.; Savel'yev, G. A.

B

TITLE: Investigation of the effect of temperature on the current-voltage characteristics of varistors intended for computing equipment

CITED SOURCE: Izv. Leningr. elektrotekhn. in-ta, vyp. 53, 1964, 301-307

TOPIC TAGS: varistor, nonlinear semiconductor resistor, semiconductor, current voltage characteristic, computer

TRANSLATION: In using the nonlinear semiconductor resistors (varistors) as voltage function generators in the computing equipment, it is necessary that the error of reproduction of the function in question be independent of ambient temperature variation. The effect of temperature on the current-voltage characteristics of a silicon-carbide varistor, in a working range of +20 + 80°C, has been investigated; this range is necessary for correct selection of the temperature-compensation method. To characterize the temperature effect on the varistor conductivity, a temperature coefficient of resistance  $k_r = \frac{1}{R_{st}} \cdot \frac{\partial R_{st}}{\partial T}$  or a temperature coefficient

Card 1/3

L 57603-65  
ACCESSION NR: AR5000577

of current  $k_1 = \frac{1}{i} \frac{\partial i}{\partial T}$  are introduced; here,  $k_{rst} = k_1$  or  $U = \text{const}$  ( $U$  is the applied voltage,  $r_{st}$  is the static resistance). Specimens of three types NPS-20-5-2, NPS-30-3-2,3<sub>4</sub> and NPS-70-1-2-,9 were measured by means of a PPTV-126 potentiometer; an M-195 galvanometer was used as a balance indicator ( $C = 4 \times 10^{-9}$  amp per one division). The outfit has a current error of  $10^{-8}$  amp and a voltage error of 1 mv. The specimens were held in a thermostat having an error of 0.1C. The measured current-voltage characteristics permit to state that the variation of the varistor temperature results not only in an increased conductivity of the silicon-carbide but also causes a variation in the nonlinearity coefficient of the varistor. Considering that the varistor nonlinearity mechanism is due to (a) the phenomenon of closure of contact gaps between the grains as the applied voltage increases, (b) microheating of the contact points between the grains which facilitates the electron emission, (c) increase in the conductance of contact layer and their partial breakdown, and (d) nonlinearity of p-n junction conductance at the grain contacts, it is assumed that, with a temperature rise caused by the inequality between the thermal expansion coefficient of silicon carbide ( $4.7 \times 10^{-6}$  per degree C) and that of ultraporcelain  $5.5 \times 10^{-6}$  per degree C), internal mechanical stresses may appear in the varistor which may change the conditions of contact between the grains. The discovered dependence of the nonlinearity

Card 2/3

L 57603-65

ACCESSION NR: AR5000577

O  
factor on temperature and the dependence of  $k_{rst}$  on voltage modify the problem of temperature compensation of the varistors used in the computing equipment. The effect of voltage on  $k_{rst}$  has to be taken into account, and the compensation methods are to be sought in which the resistor characteristics could be kept constant in the entire range of applied voltages. Four illustrations. Bibliography: 5 titles.

ENCL: 00

SUB CODE: DP, EC

Card 3/3

L 63644-65 EWP(n)/EWP(i)/EWP(b)/EWP(t) JD  
ACCESSION NR: AF5015461

UR/0146/65/008/003/0011/0016  
621.3.032

11  
10  
B

AUTHOR: Balodis, Yu. N.; Pasynkov, V. V.

TITLE: Low-voltage thin-film nonlinear elements

SOURCE: IVUZ. Priborostroyeniye, v. 8, no. 3, 1965, 11-16

TOPIC TAGS: thin film nonlinear element, silicon film, symmetric thin film, low voltage nonlinear element

ABSTRACT: G. Gass showed (Z. anorg. Chem., 1948, B. 257, S. 166) that thin amorphous films can be obtained by vacuum condensation of Si vapor onto cold glass supports. By sandwiching such films between thin aluminum strips the authors produced thin nonlinear elements whose static voltampere characteristics were symmetrical. Production procedures, the dependence of the nonlinearity coefficient on the applied voltage, and the dynamic characteristics of samples at frequencies of 50-20,000 cps are also given. Similar symmetric devices were studied by G. Feldman (Electronics, 1964, v. 37, no. 4). Orig. art. has: 2 formulas and 3 figures. [08]

Card 1/2

L 63644-65

ACCESSION NR: AP5016461

ASSOCIATION:

cheskiy institut im. V. I. Ul'yanova (Lenina)  
(Leningrad Electrical Engineering Institute)

Leningradskiy elektrotekhnicheskiy institut

SUBMITTED: 06Jun64

ENCL: 00

SUB CODE: EC

NO REF Sov: 001

OTHER: 002

ATD PRESS: 4055

YC  
Card 2/2

BOGORODITSKY, V. A.; K. M. S., . . . R. V. and others; Sov. Invent. No. 1000000.  
Electric properties of oxides of rare earth elements. Sov. Pat.

CCCP 160 no.3:572-581 Za 1964.

.. Leningradskiy elektrotekhnicheskiy institut im. I. V. Lenina. Submitted August 7, 1964.

KOROVICHKIY, S.L.; PASYUK, V.V.

Simulation of exponential and logarithmic functions by means of  
nonlinear semiconductor resistors. Inv.vys.schek.zav.; print.  
no.2:74-81 '64. TSIKHA 18.

1. Leningradskiy elektrotekhnicheskiy institut imen. Ul'yanova  
(Lenina). Rekomendovana kafedroy dielektrikev i poluprovodnikov.

ACCESSION NR: AP4037466

S/0146/64/007/002/0074/0081

AUTHOR: Korovitskiy, S. L.; Pasy\*nkov, V. V.

TITLE: Simulation of exponential and logarithmic functions by nonlinear semiconductor resistors

SOURCE: IVUZ. Priborostroyeniye, v. 7, no. 2, 1964, 74-81

TOPIC TAGS: function, exponential function, logarithmic function, function simulation, function simulation by varistors

ABSTRACT: The theory of a semiconductor-type exponential-function generator and its experimental verification are reported. The current-voltage characteristic of a silicon-carbide nonlinear resistor is described by:  $i = \sigma_0 e^{b\sqrt{U}}$ , where  $\sigma_0$  is the weak-field electric conductivity and b is a nonlinearity-characterizing constant. The parallel connection of nonlinear and linear resistors proved to possess the required exponential-function characteristic  $i = ka^m U$ . A numerical

Card 1/3

ACCESSION NR: AP4037466

calculation of the exponential-function generator is supplied. Experimental verification was conducted on a hookup whose simplified circuit is shown in Enclosure 1. By inserting the above generator into the feedback circuit of a computing amplifier, a logarithmic-function generator may be obtained. Orig. art. has: 4 figures, 9 formulas, and 4 tables.

ASSOCIATION: Leningradskiy elektrotekhnicheskiy institut im. V. I. Lenina  
(Leningrad Electrotechnical Institute)

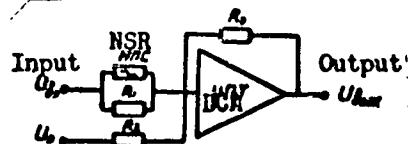
SUBMITTED: 31Oct63 / DATE ACQ: 05Jun64 ENCL: 01

SUB CODE: EC NO REF SOV: 005 OTHER: 000

Card 2/3

ACCESSION NR: AP4037466

ENCLOSURE 101



A simplified connection diagram of an  
exponential-function generator

NSR - nonlinear semiconductor resistor;

DCA - d-c amplifier

$U_b$  - bias voltage

$R_o$  - operating point setting resistor

Card 3/3

BOGORODITSKIY, Nikolay Petrovich; KAL'MENS, Natan Vladimirovich;  
NEYMAN, Moisey Isaakovich; POLYAKOVA, Natal'ya  
Lavrent'yevna; ROTENBERG, Boris Abovich; SALITRA,  
Dmitriy Borisovich; AFANAS'YEVA, Margarita Aleksandrovna;  
FRIDBERG, Illariy Dmitriyevich; Prinimala uchastiye  
MUDROLYUBOVA, L.P.; PASYNKOV, V.V., red.; ZHITNIKOVA, O.S.,  
tekhn. red.

[Ceramic materials in radio engineering] Radiokeramika. Mo-  
skva, Gosenergoizdat, 1963. 553 p. (MIRA 16:12)  
(Radio--Equipment and supplies)  
(Electric engineering--Materials)  
(Ceramic materials)

GAYLISH, Ye.A.; DROZDOV, N.G.; YEVSTROP'YEV, K.S.; KAZARNOVSKIY, D.M.; NEYMAN, L.R.; PASYINKOV, V.V.; PRIVEZENTSEV, V.A.; RENNE, V.T.; TAREYEV, B.M.

N.P. Bogoroditskii; on his sixtieth birthday and the thirty-fifth anniversary of his theoretical and educational work. Elektrichesstvo no.7:87-88 Jl '62. (MIRA 15:7)  
(Bogoroditskii, Nikolai Petrovich, 1902-)

L 29962-65 EWT(m)/EWP(t)/EWP(b) IJP(c) JD/JG

ACCESSION NR: AP5005886

S/0020/65/160/003/0578/0581

AUTHOR: Bogoroditskiy, N.P.; Pasynkov, V.V.; Rifat Rizk Basili;  
Volokobinskiy, Yu. M.

TITLE: Electrical properties of oxides of rare-earth elements

SOURCE: AN SSSR. Doklady, v. 160, no. 3, 1965, 578-581

TOPIC TAGS: rare earth element, rare earth element oxide, electrical property, electrical resistivity, electrical conductivity loss tangent, dielectric constant, optical dielectric permittivity

ABSTRACT: The electrical properties of oxides of rare-earth elements (r-e) have been investigated at temperatures up to 1300C. The temperature dependence of resistivity (see Fig. 1 of the Enclosure) showed that  $Tb_2O_3$  and  $PrO_2$  are semiconductors, while other r-e oxides can be classed as dielectrics. All r-e oxides have electron conductivity. Ion conductivity constitutes less than 0.25% of the total conductivity. The room temperature dielectric constant ( $\epsilon$ ) of  $Gd_2O_3$ ,  $Ho_2O_3$ , and  $Yb_2O_3$  is independent of the frequency in the 50-kc to 30-mc frequency range, and

Card 1/3

L 29962-65

ACCESSION NR: AP5005886

changes very slightly in the 20-300C range at a frequency of 1 mc. At 20-300C, the temperature coefficient of  $\epsilon$  for Ho<sub>2</sub>O<sub>3</sub> is practically zero, which makes Ho<sub>2</sub>O<sub>3</sub> suitable for making capacitors with stable properties. Yb<sub>2</sub>O<sub>3</sub> appears to be a likely material for making thin-film nonlinear elements. It has a cubic structure, is stable, and does not undergo phase transformations with heating in air up to the melting temperature. Metallic Yb has the lowest melting and vaporization temperatures (824 and 1477C) among the rare metals, which makes it the most suitable for making thin films by vacuum evaporation and subsequent oxidation. Orig. art. has: 3 figures and 4 tables.

ASSOCIATION: Leningradskiy elektrotekhnicheskiy institut im. V. I. Ul'yanova-Lenina (Leningrad Electrotechnical Institute)

SUBMITTED: 01Aug64

ENCL: 01

SUB CODE: IC, EM

NO REF Sov: 001

OTHER: 001

ATD PRESS: 3185

Card 2/3

L 29962-65

ACCESSION NR: AP5005886

O ENCLOSURE: 01

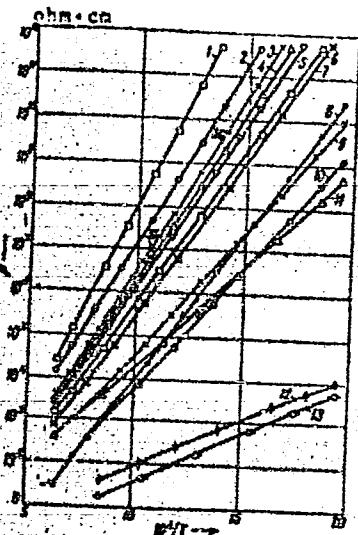


Fig. 1. Temperature dependence of resistivity

1 -  $\text{Lu}_2\text{O}_3$ ; 2 -  $\text{Er}_2\text{O}_3$ ; 3a -  $\text{Tb}_2\text{O}_3$ ;  
3b -  $\text{Gd}_2\text{O}$ ; 4 -  $\text{Dy}_2\text{O}_3$ ; 5 -  $\text{Yb}_2\text{O}_3$ ;  
6 -  $\text{Ho}_2\text{O}_3$ ; 7 -  $\text{La}_2\text{O}_3$ ; 8 -  $\text{CeO}_2$ ;  
9 -  $\text{Sm}_2\text{O}_3$ ; 10 -  $\text{Nd}_2\text{O}_3$ ; 11 -  $\text{Eu}_2\text{O}_3$ ;  
12 -  $\text{Tb}_2\text{O}_3$ ; 13 -  $\text{Pr}_2\text{O}_3$ .

Card 3/3

PASYNKOV, V. V., doktor tekhn. nauk, prof.; CHIRKIN, L. K., kand.  
tekhn. nauk

Third Interuniversity Conference on Present Dielectrics and  
Semiconductors Technology. Izv. LETI 59 no.46:348-350 '62.  
(MIRA 15:10)

(Dielectrics—Congresses)  
(Semiconductors—Congresses)

3/058/62/000/011/048/061  
A160/A101

AUTHORS: Pasynkov, V. V., Chirkin, L. K.

TITLE: The Third Inter-University Conference on the Present State of Di-electric and Semiconductor Engineering, 13 - 18 June 1960

PERIODICAL: Referativnyy zhurnal, Fizika, no. 11, 1962, 1, abstract 11-4-1k  
("Izv. Leningr. elekrotekhn. in-ta", no. 46, 1961, 348 - 350)

TEXT: The Third Inter-University Conference on the Present State of Di-electric and Semiconductor Engineering was held in LETI from 13 to 18 June 1960. The conference heard and discussed 178 reports. A total of 1,249 persons, representatives of 34 towns of the USSR and of the east-bloc countries participated in it. It is noted that side-by-side with great achievements in the work of higher educational institutions on dielectrics and semiconductors, there are serious deficiencies, especially inadequate work done by higher educational institutions in the field of ferrite application. Mentioned in the conference resolution was the necessity to increase scientific research work, especially in the field of heat-resisting insulation, inorganic polymers, organic semiconductors,

Card 1/2

The Third Inter-University Conference on the...

3/05/62/CCC/11.4  
A160/A101

highly-resistant materials, the reliability of semiconductor devices, and determining their stability and temperature work range. The conference decided to recommend that the Fourth Conference be called for 1962.

L. Sh.

[Abstracter's note: Complete translation]

Card 2/2

PASYNKOV, Vladimir Vasil'yevich; CKUNEV, Yuriy Timofeyevich;  
PREGER, D.P., red.izd-va; BELOGUROVA, I.A., tekhn. red.

[Nonlinear semiconductor resistors (varistors)] Nelineinyye  
poluprovodnikovye sопrotivleniya (varistory). Leningrad,  
Leningr. dom nauchno-tekhn. propagandy, 1963. 34 p.  
(Serija: "Poluprovodniki," no.11) (MIRA 16:11)  
(Semiconductors) (Electric resistors)

PASYNKOVA, Ye. I.; SOROKOUMOV, V.N. (Moskva)

Niels Finsen (100th anniversary of his birth). Vop. kur.,  
fizioter. i lech. fiz. kul't. 26 no.5:473-474 8-0 '61.  
(MIRA 14:11)  
(FINSEN, NIELS RIJBERG, 1860-1904)

PASYNKOV, Ye. I.

[Textbook on physical therapy] Uchebnik fizioterapii. Moskva, Medgiz,  
1957. 291 p. (MIRA 11:6)  
(PHYSICAL THERAPY)

PIONTKOVSKIY, I.A., professor, redaktor; ANIKIN, M.N., dotsent,  
redaktor; VARSHAVER, G.S., dotsent, redaktor; MANIKOV, M.Ye.,  
starshiy nauchnyy sotrudnik, redaktor; OBROSOV, A.N., professor,  
redaktor; PASYMKOV, Ye.I., professor, redaktor.

[Problems of physiotherapy: joint-plenum of the administration  
of the All-Union Society of Physiotherapists and the Scientific  
Council of the State Physiotherapy Scientific Research Institute  
of the Ministry of Health of the R.S.F.S.R.] Voprosy fizioterapii;  
ob"edinennyi plenum pravleniya Vsesoiuznogo obshchestva fizio-  
terapevtov i uchenogo soveta Gosudarstvennogo nauchno-issledo-  
vatel'skogo instituta fizioterapii Ministerstva zdravookhrane-  
niya RSFSR. Moskva, 29 iiunia- 2 iulija 1951 g. Moskva, Medgiz,  
1953. 239 p. (MLRA 7:2)

1. Vsesoyuznoye obshchestvo fizioterapevtov. (Physical therapy)

PASYNKOv, Ye. I.; RUBIN, L.R.; GLASKO, N.M., redaktor; GIUKHOYEDOVA, G.A.,  
tekhnicheskiy redaktor

[General physical therapy; brief course] Obshchaya fizioterapiia;  
kratkiy kurs. Izd. 3-e. Moskva, Gos. izd-vo meditsinskoi lit-ry,  
1955. 253 p.

(PHYSICAL THERAPY)

PASYNKOV, Ye. I.; PUTILIN, T. V.; YAKUB, I. A.; FIDRUS, I. Yu.

"Penicillin in Prophylactics of Suppuration of Postoperative Wounds,"  
Voyenno-Med. Zhur., No. 6, p. 32, 1955.

PASYNKOV, Yefim Izrailevich. Prinimal uchastiye SHAMRAYEVSKIY, S.M.,  
dots.; MANIKOV, M.Ye., red.; ZUYEVA, N.K., tekhn. red.

[General physiotherapy] Obshchaia fizioterapiia. Moskva,  
Medgiz, 1962. 350 p. (MIRA 15:3)  
(PHYSICAL THERAPY)

PASYNKOV, Yefim Izrailevich. Prinimali uchastiye: SHAMRAYEVSKIY,  
S.F., dots.; PRISYLOV, K.N., kand. med. nauk; MANKOV,  
M.Ye., red.

[Physiotherapy] Fizioterapiia. Iza.2. Moskva, Meditsina,  
1966. 310 p. (N.I.G. 19:1)

OBROSOV, A.N.; VINOGRADOV, N.D.; PASYNIKOV, Ye.N.

I.A.Piontkovskii. Vop.kur.,fizioter. i lech. fiz. kul't.  
27 no.5:468-869 S-0'63. (MIHA 16.9)  
(PIONTKOVSKII, IGOR' ANDREEVICH, 1902 - )

SELETSKAYA, T.S.; PASYNKOVA, I.Ye.

Working conditions of personnel operating closed radioactive  
sources in medical institutions. Med.rad. 5 no.2:66-72 F '60.  
(MIRA 13:12)  
(RADIATION PROTECTION)

IASYNKOVA, K. N.

"The Problem of the Functional Condition of the Nervous System of Rheumatic Patients." Cand Med Sci, First Leningrad Medical Inst, Leningrad, 1955.  
(RZhBiol, No 7, Apr 55)

SO: Sum. No 704, 2 Nov 55 - Survey of Scientific and Technical Dissertations  
Defended at USSR Higher Educational Institutions (16).

PASYNKOVA, K.N., kand.med.nauk

Use of a new Soviet cholagogic substance oxaphenamide in the compound treatment of cholecystitis. Terap.arkh. no.7:82-84  
Jl '62. (MIRA 15:8)

1. Iz kafedry fakul'tetskoy terapii (zav. - prof. B.P. Kushelevskiy) Sverdlovskogo meditsinskogo instituta.  
(SALICYLAMIDE) (GALL BLADDER-DISEASES)

PASYNKOVA, K.N., kand.med.nauk

Use of a new Soviet cholagogic substance oxaphenamide in the compound treatment of cholecystitis. Terap.arkh. no.7:82-84 Jl '62. (MIRA 15:8)

1. Iz kafedry fakul'tetskoy terapii (zav. - prof. B.P. Kushalev-skiy) Sverdlovskogo meditsinskogo instituta.  
(SALICYLAMIDE) (GALL BLADDER--DISEASES)

KUSHELEVSKIY, B.P., zasluzhennyy deyatel' nauki, prof.; PASYNKOVA, K.N.,  
kand.med. nauk (Sverdlovsk)

Botkin's cholecysto-coronary syndrome. Klin. med. 41 no.7  
9-12 Jl '63 (MIRA 16:12)

1. Iz kliniki fakultetskoy terapii Sverdlovskogo gosudarstvenno-geditsinskogo instituta.

PASYNKOVA, K.N.

KUSHELEVSKIY, B.P., prof.; PASYNKOVA, K.N., kand.med.nauk

"Problems in the pathogenesis, clinical aspects, and treatment  
of rheumatic fever." Reviewed by B.P.Kushelevskii, K.N.Pasynkova.  
Sov.med. 22 no.2:152-155 F '58. (MIRA 11:4)  
(RHEUMATIC FEVER)

KORYAGIN, G.A.; KRASNOVA, G.S.; PASYNKOVA, Z.T.; MAKHOV, D.S.

Communication workers discuss their work practices. Avtov.,  
telem. i sviaz' 9 no.3:28 Mr '65. (MIRA 18:11)

1. Rabotniki Novosibirskoy distantsii Zapadno-Sibirskskoy dorogi.

PASYNOK, M.V.; FRISH, V.A. (Sverdlovsk); KUPRIN, M.

Letters to the editor. Geog.v shkole 24 no.3:65-68 My-Je '61.  
(MIRA 14:5)

1. Nedryanskaya shkola Kiyevskiy oblasti (for Pasynok). 2. 14-ya  
shkola g. Kurgana (for Kuprin).  
(Physical geography—Study and teaching)